



ALPHA & OMEGA
SEMICONDUCTOR

AONV420A70

700V, α MOS5™ N-Channel Power Transistor

General Description

- Proprietary α MOS5™ technology
- Low $R_{DS(ON)}$
- Optimized switching parameters for better EMI performance
- Enhanced body diode for robustness and fast reverse recovery

Applications

- Flyback for SMPS
- Charger, PD Adapter, TV, lighting

Product Summary

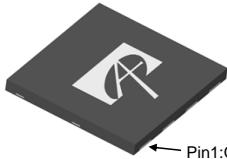
V_{DS} @ $T_{j,max}$	800V
I_{DM}	46A
$R_{DS(ON),max}$	< 0.42Ω
$Q_{g,typ}$	21.5nC
E_{oss} @ 400V	2.8μJ

100% UIS Tested
100% R_g Tested

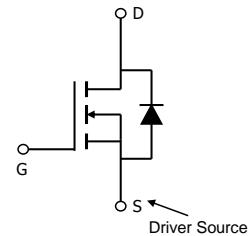
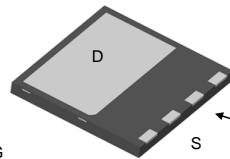


DFN8X8

Top View



Bottom View



Orderable Part Number	Package Type	Form	Minimum Order Quantity
AONV420A70	DFN8x8_4L_EP1_S	Tape & Reel	3500

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	700	V
Gate-Source Voltage	V_{GS}	± 20	V
Gate-Source Voltage (dynamic) AC($f>1\text{Hz}$)	V_{GS}	± 30	V
Continuous Drain Current ^A $T_C=25^\circ\text{C}$	I_D	12	A
Continuous Drain Current ^A $T_C=100^\circ\text{C}$	I_D	7.5	
Pulsed Drain Current ^C	I_{DM}	46	
Continuous Drain Current ^A $T_A=25^\circ\text{C}$	I_{DSM}	2.8	A
Continuous Drain Current ^A $T_A=70^\circ\text{C}$	I_{DSM}	2.2	
Avalanche Current ^C	I_{AR}	3.4	A
Repetitive avalanche energy ^C	E_{AR}	5.8	mJ
Single pulsed avalanche energy ^G	E_{AS}	50	mJ
MOSFET dv/dt ruggedness	dv/dt	100	V/ns
Diode reverse recovery	dv/dt	20	V/ns
$V_{DS}=0$ to 400V, $I_F \leq 12\text{A}$, $T_j=25^\circ\text{C}$	di/dt	500	A/us
Power Dissipation ^B $T_C=25^\circ\text{C}$	P_D	156	W
Power Dissipation ^B Derate above 25°C	P_D	1.3	$\text{W}/^\circ\text{C}$
Power Dissipation ^A $T_A=25^\circ\text{C}$	P_{DSM}	8.3	W
Power Dissipation ^A $T_A=70^\circ\text{C}$	P_{DSM}	5.3	$\text{W}/^\circ\text{C}$
Junction and Storage Temperature Range	T_J , T_{STG}	-55 to 150	°C
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	T_L	300	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A $t \leq 10\text{s}$	$R_{\theta JA}$	12	15	$^\circ\text{C/W}$
Maximum Junction-to-Ambient ^{A,D} Steady-State	$R_{\theta JA}$	40	50	$^\circ\text{C/W}$
Maximum Junction-to-Case Steady-State	$R_{\theta JC}$	0.51	0.80	$^\circ\text{C/W}$

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V, T _J =25°C	700			V
		I _D =250μA, V _{GS} =0V, T _J =150°C		800		
BV _{DSS} / ΔT_J	Breakdown Voltage Temperature Coefficient	I _D =250μA, V _{GS} =0V		0.6		V/°C
		V _{DS} =700V, V _{GS} =0V			1	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =560V, T _J =125°C			10	μA
		V _{DS} =0V, V _{GS} =±20V			±100	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =5V, I _D =250μA	3.4	4	4.6	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =6A		0.38	0.42	Ω
g _{FS}	Forward Transconductance	V _{DS} =10V, I _D =6A		8.6		S
V _{SD}	Diode Forward Voltage	I _S =6A, V _{GS} =0V		0.87	1.2	V
I _S	Maximum Body-Diode Continuous Current				12	A
I _{SM}	Maximum Body-Diode Pulsed Current ^C				46	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =100V, f=1MHz		1360		pF
C _{oss}	Output Capacitance			34		pF
C _{o(er)}	Effective output capacitance, energy related ^I	V _{GS} =0V, V _{DS} =0 to 480V, f=1MHz		32		pF
C _{o(tr)}	Effective output capacitance, time related ^J			147		pF
C _{rss}	Reverse Transfer Capacitance	V _{GS} =0V, V _{DS} =100V, f=1MHz		1.7		pF
R _g	Gate resistance	f=1MHz		2		Ω
SWITCHING PARAMETERS						
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =480V, I _D =6A		21.5		nC
Q _{gs}	Gate Source Charge			10		nC
Q _{gd}	Gate Drain Charge			6		nC
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =400V, I _D =6A, R _G =5Ω		24.5		ns
t _r	Turn-On Rise Time			17		ns
t _{D(off)}	Turn-Off DelayTime			34.5		ns
t _f	Turn-Off Fall Time			13		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =6A, dI/dt=100A/μs, V _{DS} =400V		310		ns
I _{rm}	Peak Reverse Recovery Current			24.5		A
Q _{rr}	Body Diode Reverse Recovery Charge			4.8		μC

A. The value of R_{θJA} is measured with the device in a still air environment with T_A=25° C.

B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

G. L=60mH, I_{AS}=1.3A, R_G=25Ω, Starting T_J=25° C.

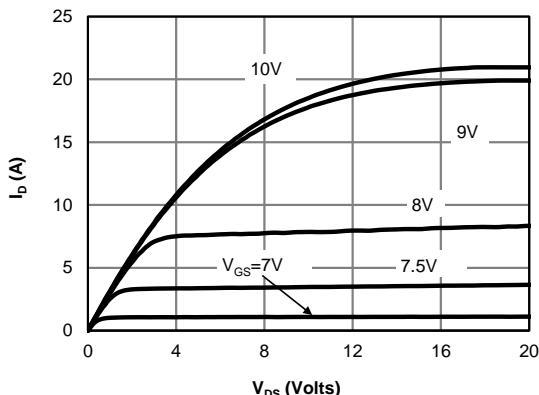
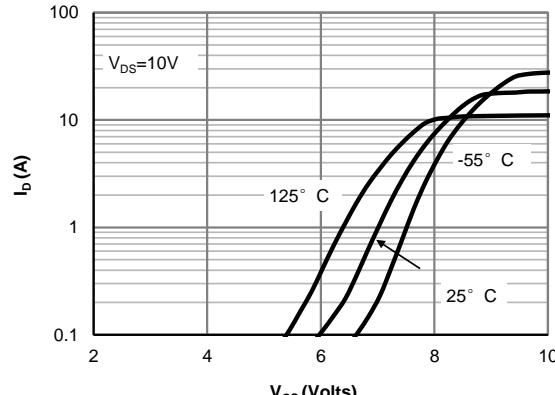
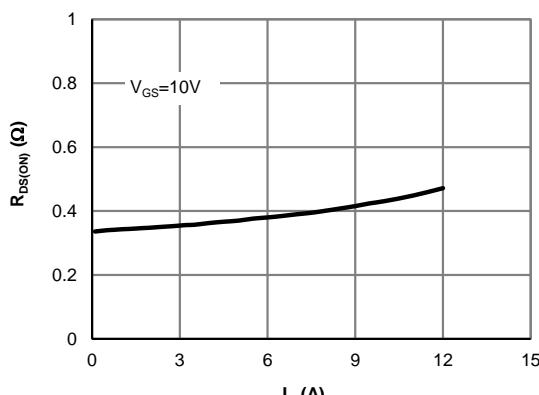
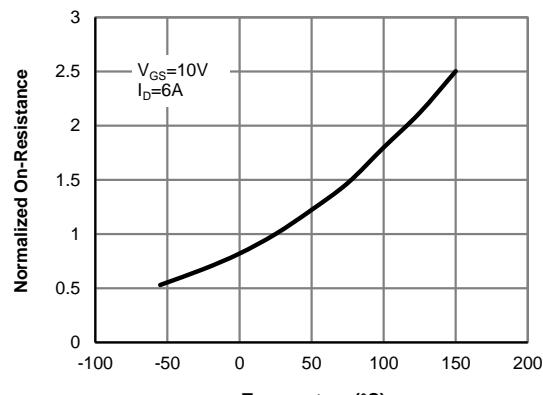
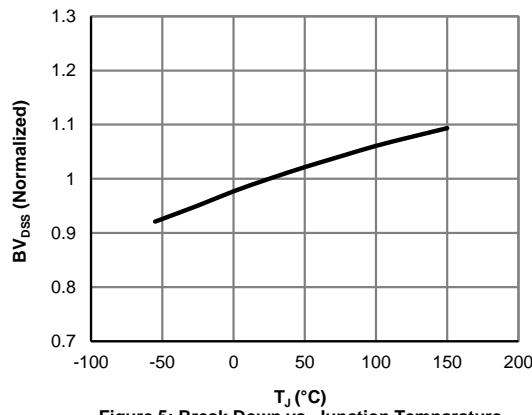
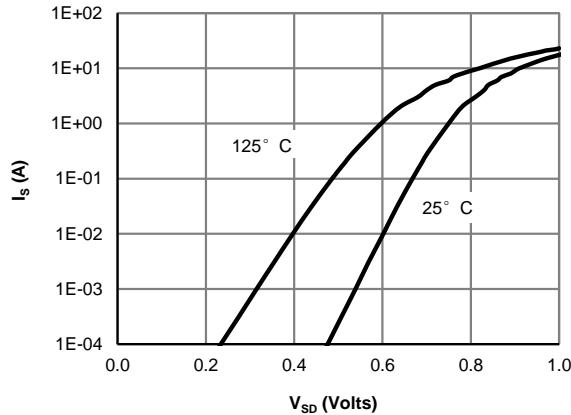
H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C

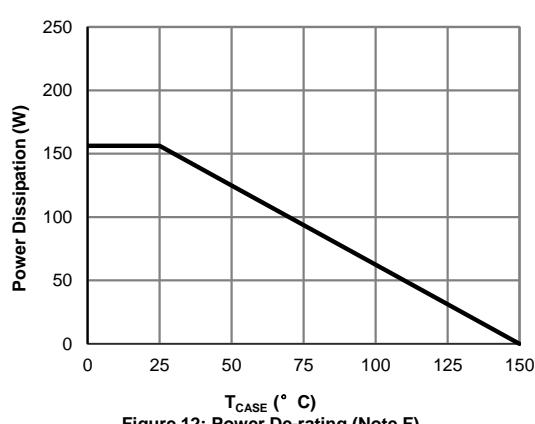
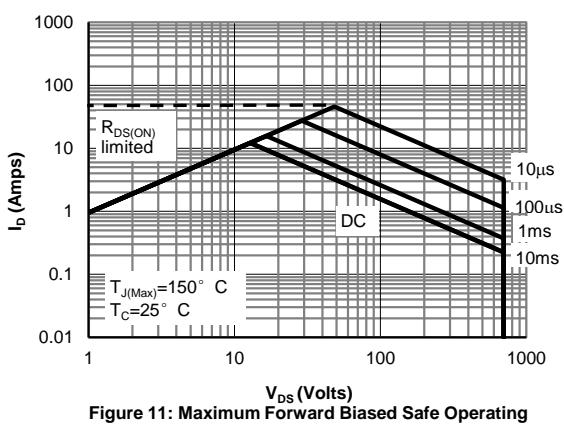
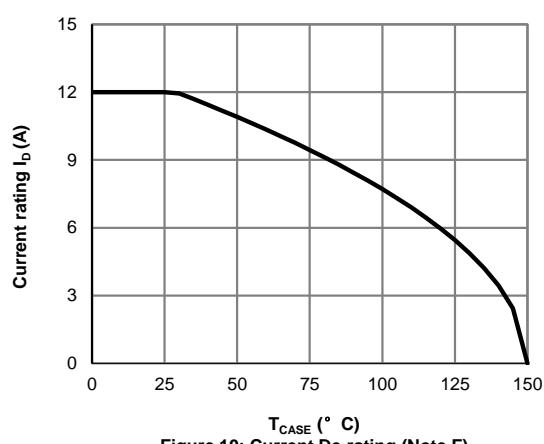
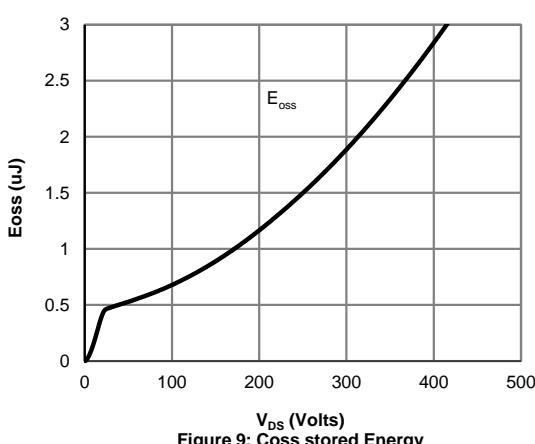
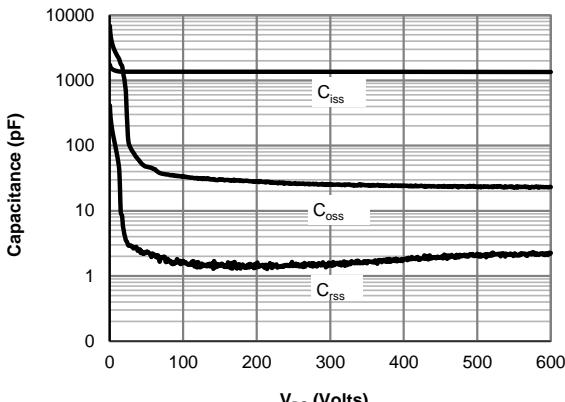
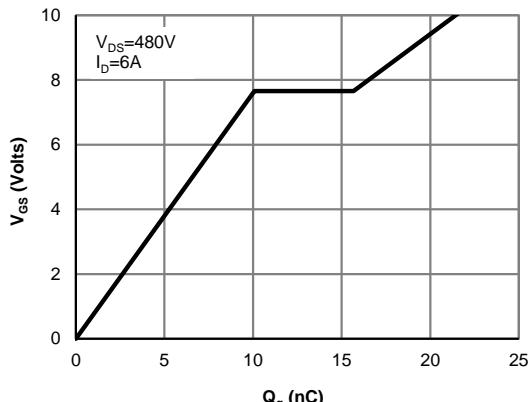
I. C_{o(er)} is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{(BR)DSS}.

J. C_{o(tr)} is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{(BR)DSS}.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 1: On-Region Characteristics

Figure 2: Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature

Figure 5: Break Down vs. Junction Temperature

Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


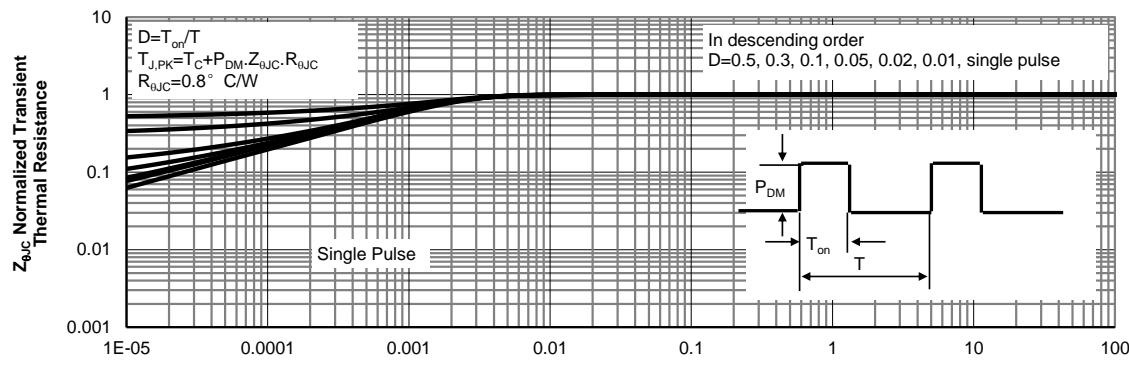
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


Figure 13: Normalized Maximum Transient Thermal Impedance (Note F)

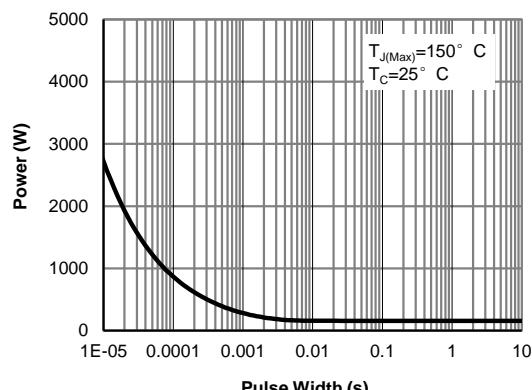


Figure 14: Single Pulse Power Rating Junction-to-Case (Note F)

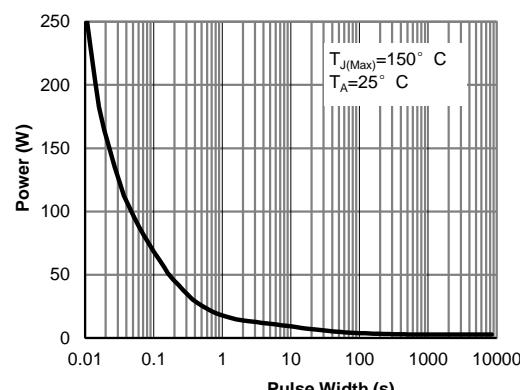


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

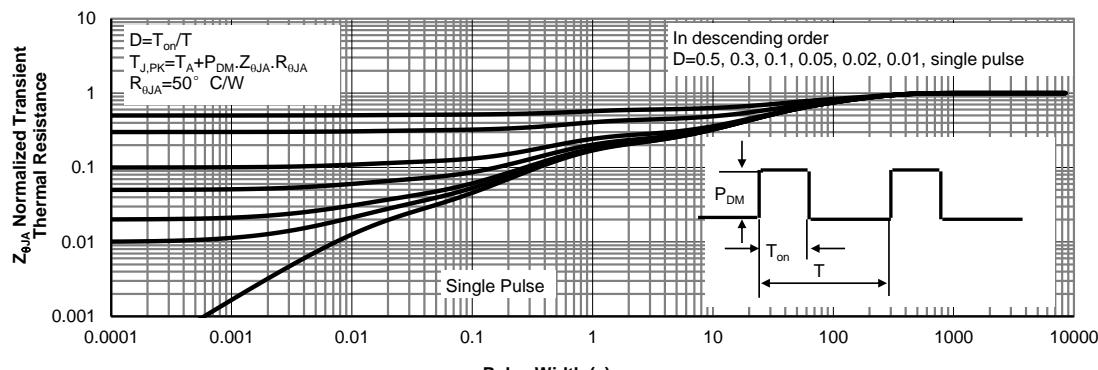
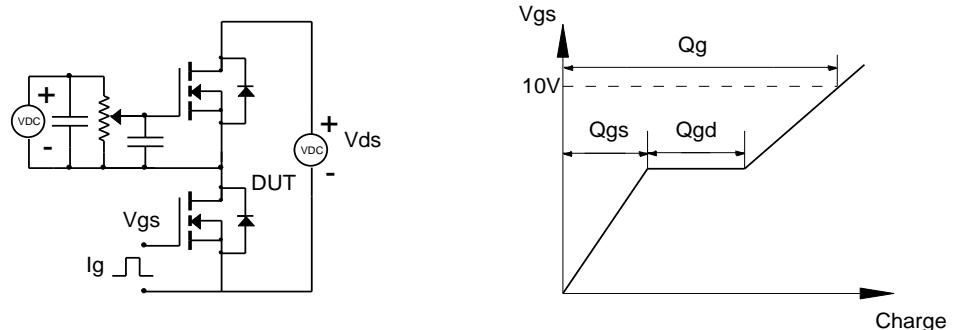
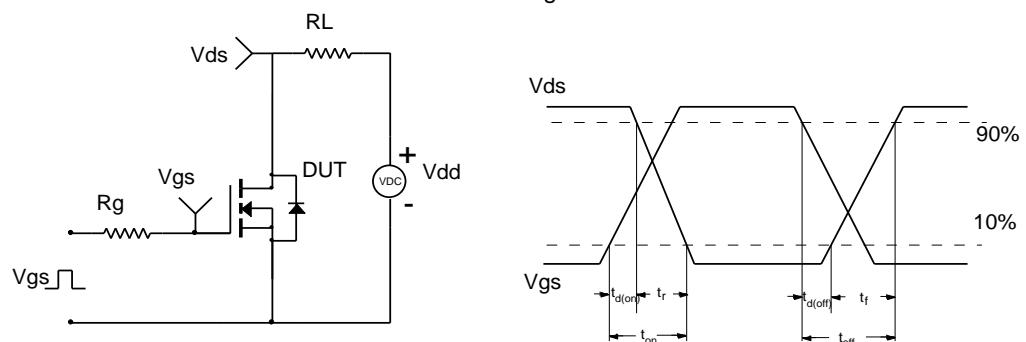
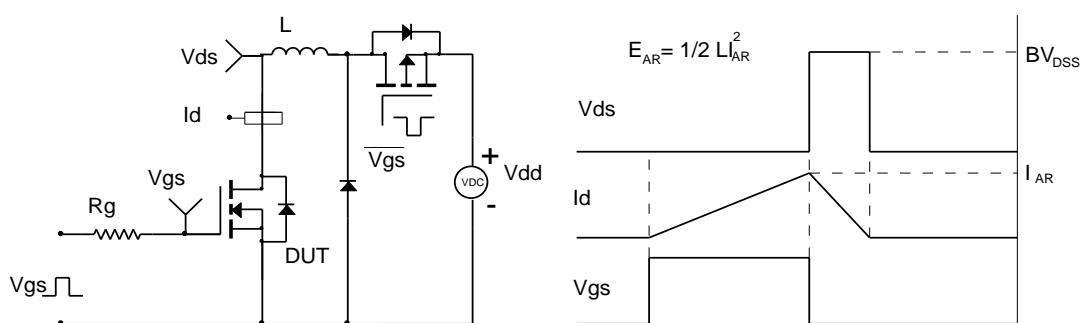


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms
